

System Check_13MHz_260606

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	200.0 x 200.0 x 80.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 0.00	CLA13	CW, -	13.000, 4	16.7	0.717	53.2

Hardware Setup

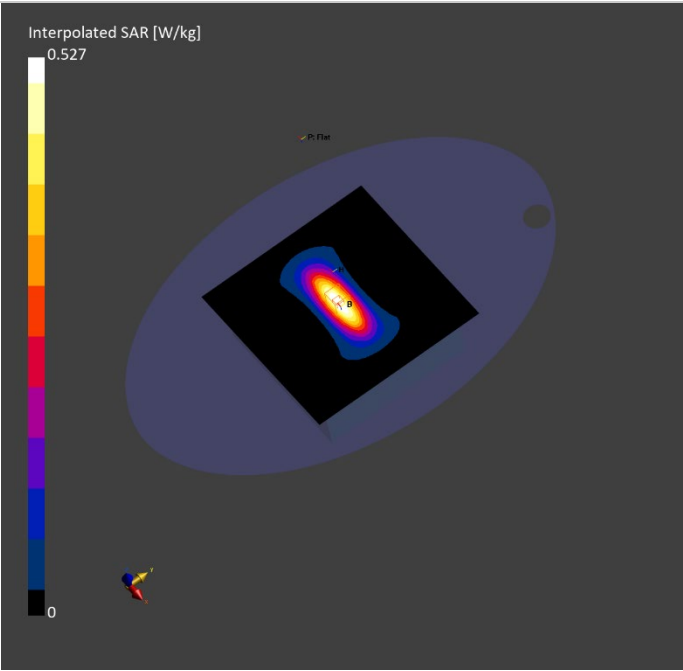
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL13-2026-06-06	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	240.0 x 240.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-06	2026-06-06
psSAR1g [W/kg]	0.492	0.474
psSAR10g [W/kg]	0.394	0.293
Power Drift [dB]	-0.02	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		72.8
Dist 3dB Peak [mm]		15.8



System Check_HSL750_260522

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 750 MHz D750V3,	10.0 x 10.0 x 330.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 15.00	D750	CW, -	750.000, 50	9.13	0.893	43.9

Hardware Setup

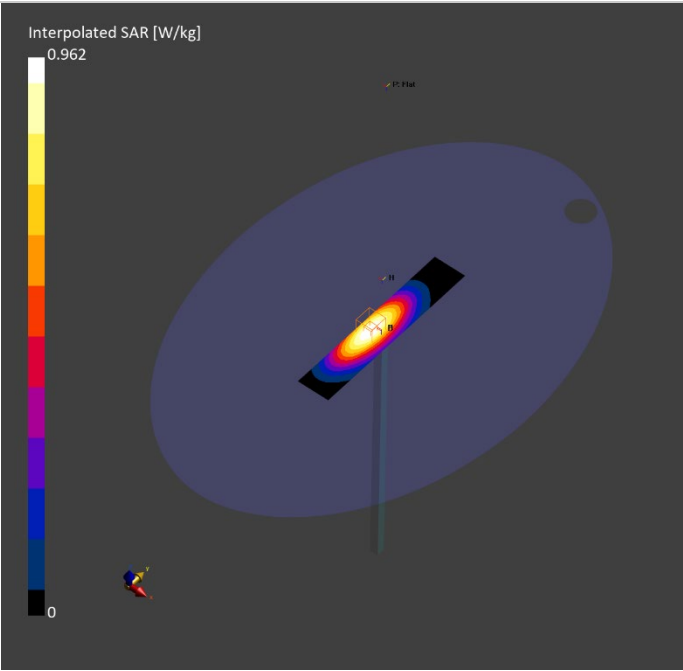
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL750-2026-05-22	EX3DV4 - SN7801, 2025-07-22	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-05-22	2026-05-22
psSAR1g [W/kg]	0.837	0.847
psSAR10g [W/kg]	0.565	0.556
Power Drift [dB]	-0.02	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		86.6
Dist 3dB Peak [mm]		15.0



System Check_HSL835_260523

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 835 MHz D835V2,	10.0 x 10.0 x 340.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 15.00	D835	CW, -	835.000, 50	8.95	0.925	43.5

Hardware Setup

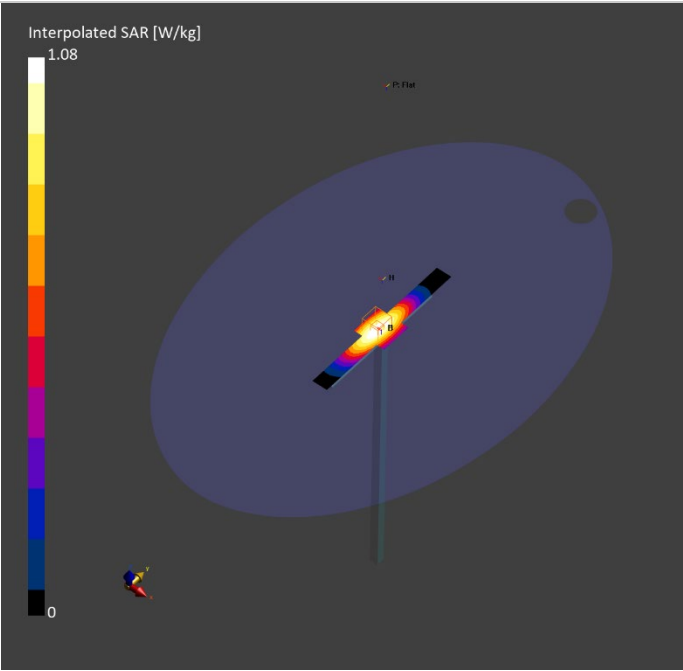
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL835-2026-05-23	EX3DV4 - SN7801, 2025-07-22	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 200.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-05-23	2026-05-23
psSAR1g [W/kg]	0.941	0.948
psSAR10g [W/kg]	0.622	0.618
Power Drift [dB]	0.00	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		85.4
Dist 3dB Peak [mm]		22.2



System Check_HSL900_260524

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 900 MHz D900V2,	10.0 x 10.0 x 340.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 15.00	D900	CW, -	900.000, 50	8.85	0.931	42.0

Hardware Setup

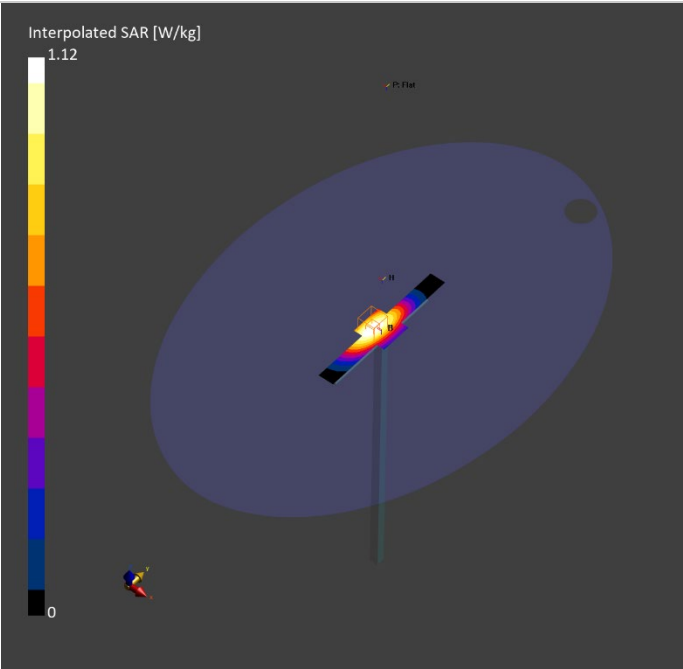
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL900-2026-05-24	EX3DV4 - SN7801, 2025-07-22	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 180.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-05-24	2026-05-24
psSAR1g [W/kg]	0.972	0.983
psSAR10g [W/kg]	0.641	0.634
Power Drift [dB]	0.04	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		86.1
Dist 3dB Peak [mm]		17.8



System Check_HSL1750_260611

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 1750 MHz D1750V2,	10.0 x 10.0 x 302.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D1750	CW, -	1750.000, 50	7.46	1.40	40.2

Hardware Setup

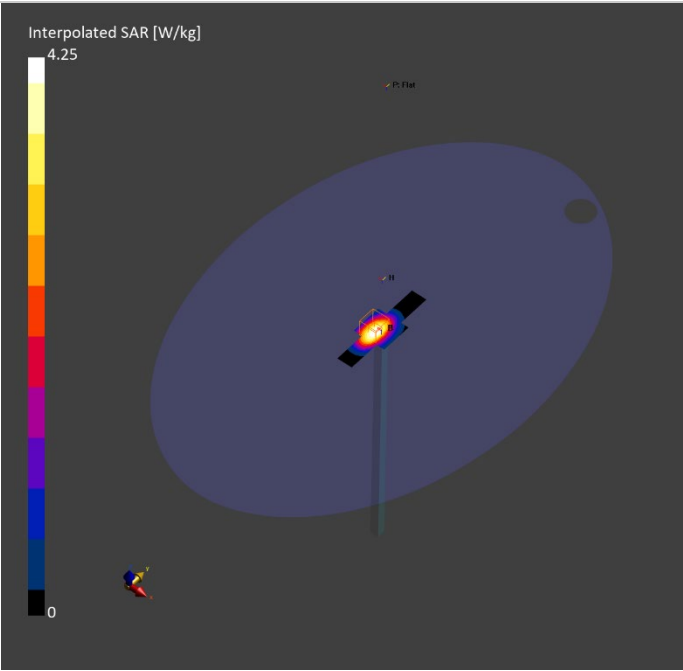
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL1750-2026-06-11	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 120.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-11	2026-06-11
psSAR1g [W/kg]	3.46	3.51
psSAR10g [W/kg]	1.89	1.89
Power Drift [dB]	-0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		83.5
Dist 3dB Peak [mm]		10.9



System Check_HSL1750_260612

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 1750 MHz D1750V2,	10.0 x 10.0 x 302.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D1750	CW, -	1750.000, 50	7.46	1.40	40.4

Hardware Setup

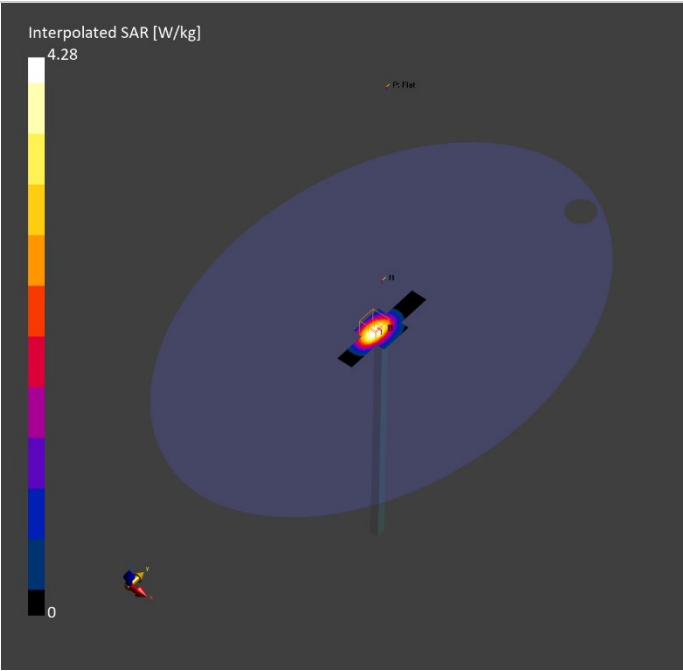
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL1750-2026-06-12	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 120.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-12	2026-06-12
psSAR1g [W/kg]	3.48	3.56
psSAR10g [W/kg]	1.90	1.91
Power Drift [dB]	-0.00	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		82.5
Dist 3dB Peak [mm]		10.8



System Check_HSL1950_260613

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 1950 MHz D1950V3,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D1950	CW, -	1950.000, 50	7.24	1.42	40.7

Hardware Setup

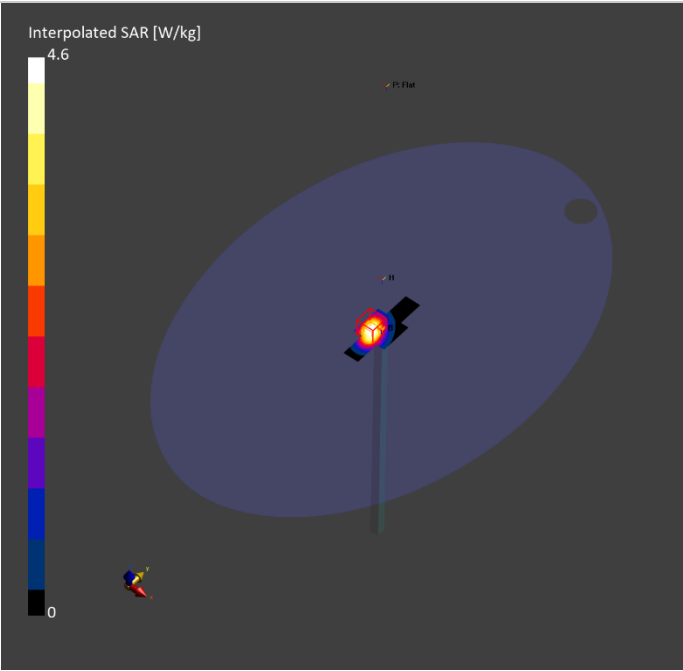
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL1950-2026-06-13	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-13	2026-06-13
psSAR1g [W/kg]	3.72	3.86
psSAR10g [W/kg]	2.00	2.00
Power Drift [dB]	0.00	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		80.5
Dist 3dB Peak [mm]		10.3



System Check_HSL1950_260614

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 1950 MHz D1950V3,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D1950	CW, -	1950.000, 50	7.24	1.43	40.8

Hardware Setup

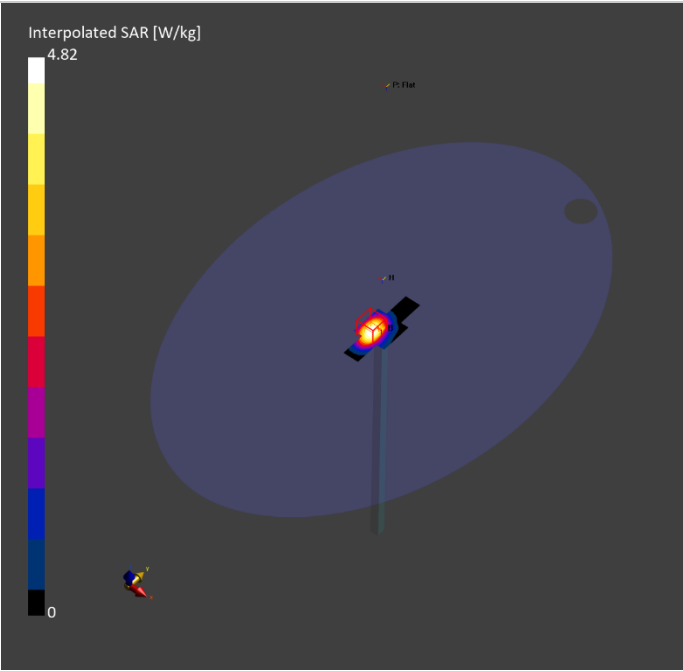
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL1950-2026-06-14	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-14	2026-06-14
psSAR1g [W/kg]	3.91	4.05
psSAR10g [W/kg]	2.10	2.10
Power Drift [dB]	-0.05	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		80.2
Dist 3dB Peak [mm]		10.3



System Check_HSL2300_260615

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 2300 MHz D2300V2,	10.0 x 10.0 x 290.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D2300	CW, -	2300.000, 50	6.87	1.65	38.1

Hardware Setup

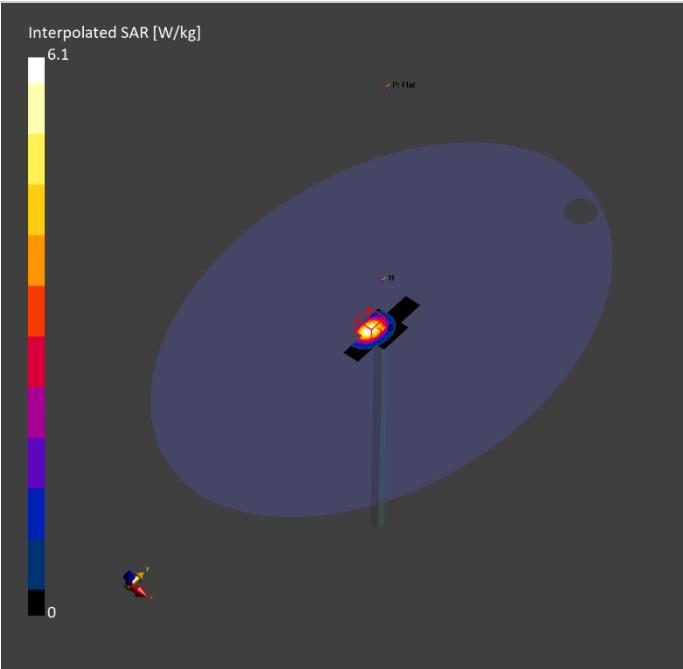
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL2300-2026-06-15	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-15	2026-06-15
psSAR1g [W/kg]	4.73	4.84
psSAR10g [W/kg]	2.35	2.34
Power Drift [dB]	0.00	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		82.3
Dist 3dB Peak [mm]		9.3



System Check_HSL2450_260602

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 2450 MHz D2450V2,	10.0 x 10.0 x 290.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D2450	CW, -	2450.000, 50	6.67	1.76	38.6

Hardware Setup

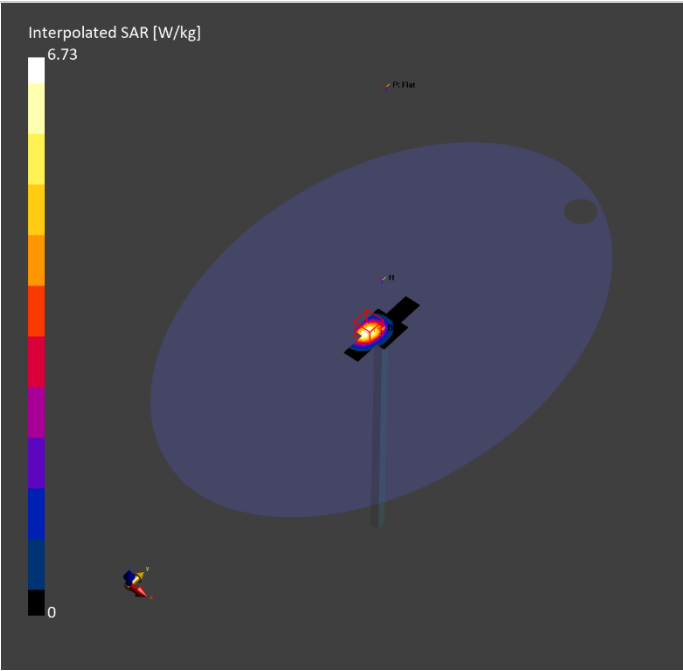
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL2450-2026-06-02	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-02	2026-06-02
psSAR1g [W/kg]	5.24	5.36
psSAR10g [W/kg]	2.56	2.52
Power Drift [dB]	0.01	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		81.0
Dist 3dB Peak [mm]		9.0



System Check_HSL2450_260604

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 2450 MHz D2450V2,	10.0 x 10.0 x 290.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D2450	CW, -	2450.000, 50	6.67	1.75	38.5

Hardware Setup

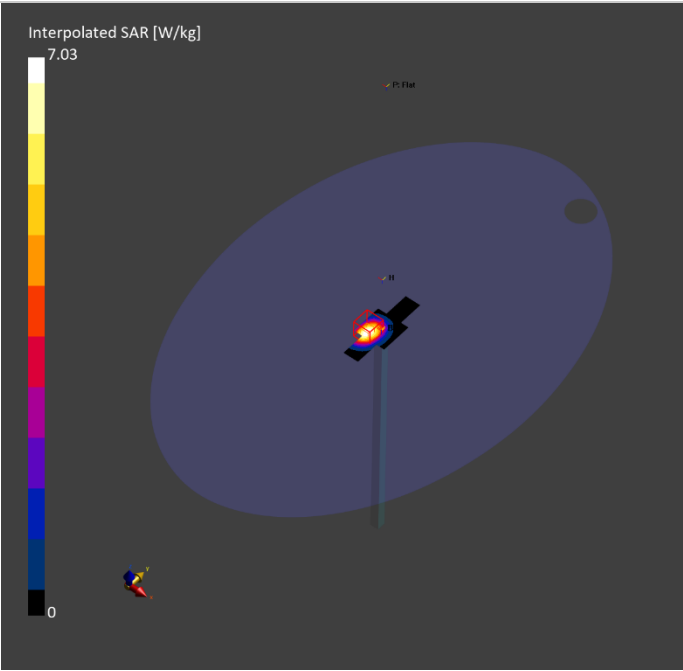
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL2450-2026-06-04	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-04	2026-06-04
psSAR1g [W/kg]	5.48	5.60
psSAR10g [W/kg]	2.67	2.64
Power Drift [dB]	0.00	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		81.0
Dist 3dB Peak [mm]		9.0



System Check_HSL2550_260619

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 2550 MHz D2550V2,	10.0 x 10.0 x 290.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D2550V2	CW, -	2550.000, 50	6.49	1.85	37.3

Hardware Setup

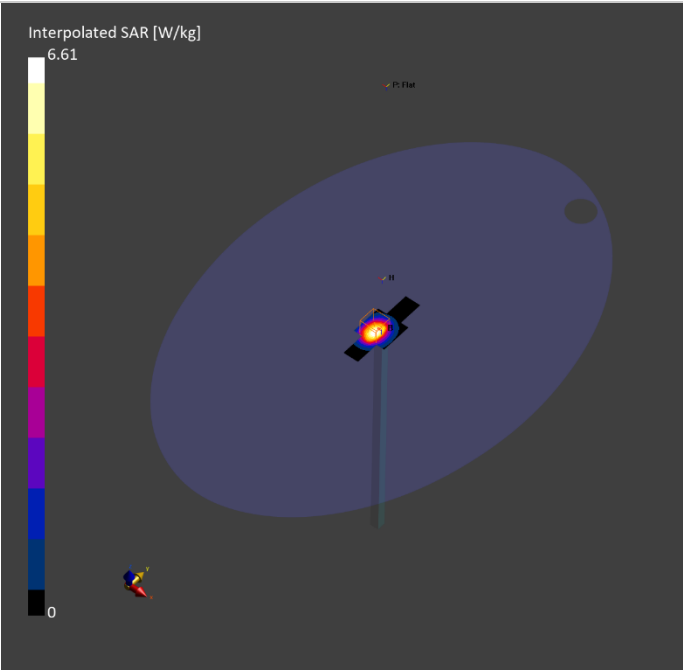
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL2550-2026-06-19	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-19	2026-06-19
psSAR1g [W/kg]	5.08	5.24
psSAR10g [W/kg]	2.38	2.41
Power Drift [dB]	0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		78.9
Dist 3dB Peak [mm]		9.3



System Check_HSL2550_260620

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 2550 MHz D2550V2,	10.0 x 10.0 x 290.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D2550V2	CW, -	2550.000, 50	6.49	1.86	37.4

Hardware Setup

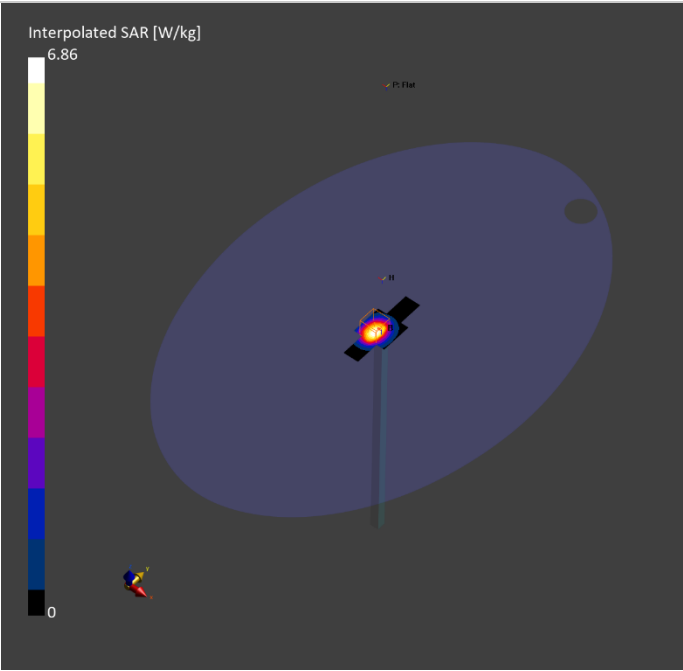
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL2550-2026-06-20	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-20	2026-06-20
psSAR1g [W/kg]	5.27	5.45
psSAR10g [W/kg]	2.47	2.51
Power Drift [dB]	0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		79.0
Dist 3dB Peak [mm]		9.5



System Check_HSL2550_260621

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 2550 MHz D2550V2,	10.0 x 10.0 x 290.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D2550V2	CW, -	2550.000, 50	6.49	1.84	37.2

Hardware Setup

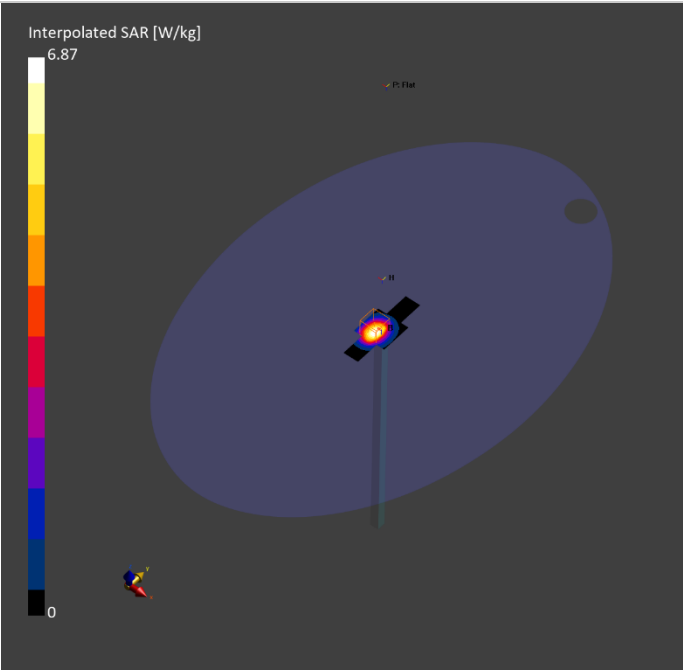
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL2550-2026-06-21	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 100.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-21	2026-06-21
psSAR1g [W/kg]	5.28	5.47
psSAR10g [W/kg]	2.47	2.52
Power Drift [dB]	0.00	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		78.9
Dist 3dB Peak [mm]		9.5



System Check_HSL3500_260607

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3500 MHz D3500V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3500	CW, -	3500.000, 50	6.15	2.84	36.5

Hardware Setup

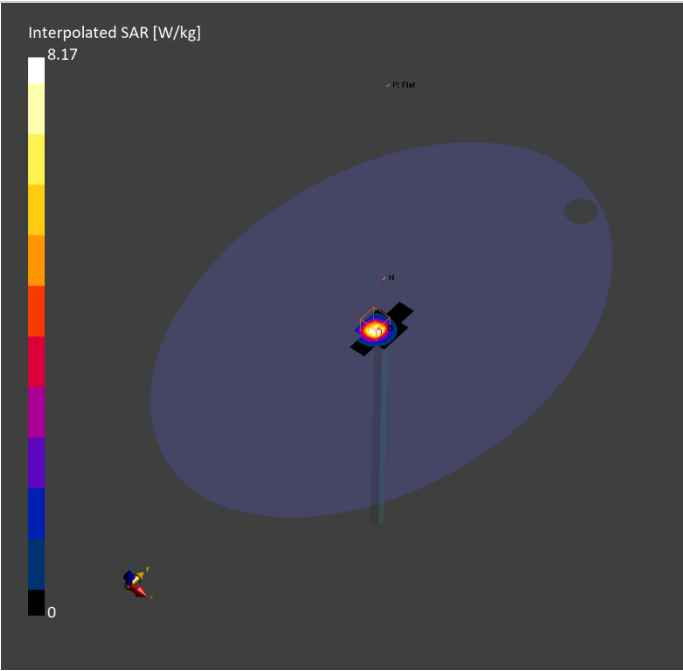
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3500-2026-06-07	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-07	2026-06-07
psSAR1g [W/kg]	6.13	6.59
psSAR10g [W/kg]	2.53	2.60
Power Drift [dB]	0.01	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.6
Dist 3dB Peak [mm]		9.0



System Check_HSL3500_260608

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3500 MHz D3500V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3500	CW, -	3500.000, 50	6.15	2.80	36.1

Hardware Setup

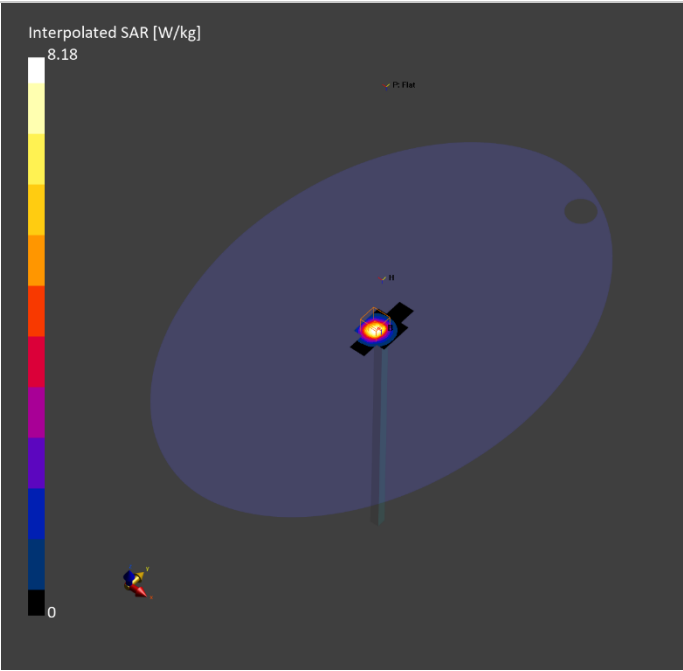
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3500-2026-06-08	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-08	2026-06-08
psSAR1g [W/kg]	6.14	6.65
psSAR10g [W/kg]	2.53	2.62
Power Drift [dB]	0.00	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.4
Dist 3dB Peak [mm]		9.0



System Check_HSL3500_260629

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3500 MHz D3500V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3500	CW, -	3500.000, 50	6.15	2.82	36.3

Hardware Setup

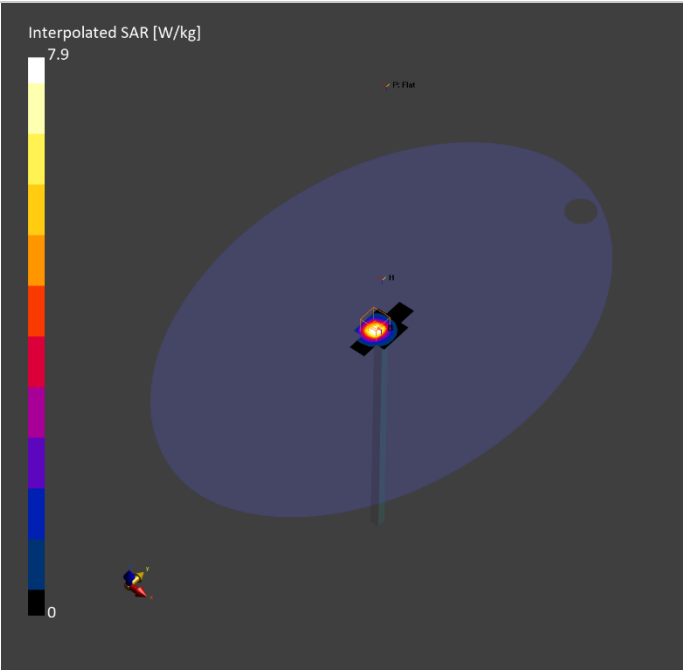
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3500-2026-06-29	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-29	2026-06-29
psSAR1g [W/kg]	5.93	6.41
psSAR10g [W/kg]	2.44	2.52
Power Drift [dB]	0.01	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.3
Dist 3dB Peak [mm]		9.0



System Check_HSL3500_260702

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3500 MHz D3500V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3500	CW, -	3500.000, 50	6.15	2.91	36.8

Hardware Setup

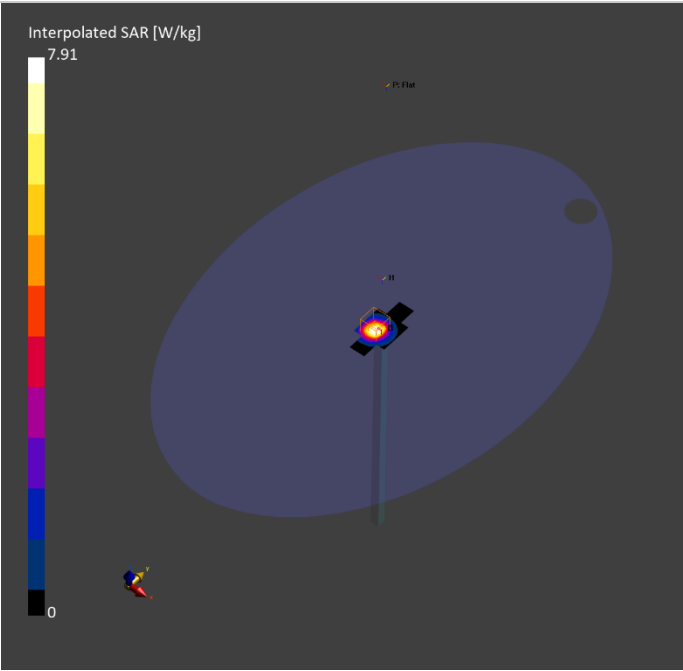
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3500-2026-07-02	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-02	2026-07-02
psSAR1g [W/kg]	5.94	6.42
psSAR10g [W/kg]	2.45	2.53
Power Drift [dB]	-0.01	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.4
Dist 3dB Peak [mm]		9.0



System Check_HSL3500_260703

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3500 MHz D3500V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3500	CW, -	3500.000, 50	6.15	2.87	36.7

Hardware Setup

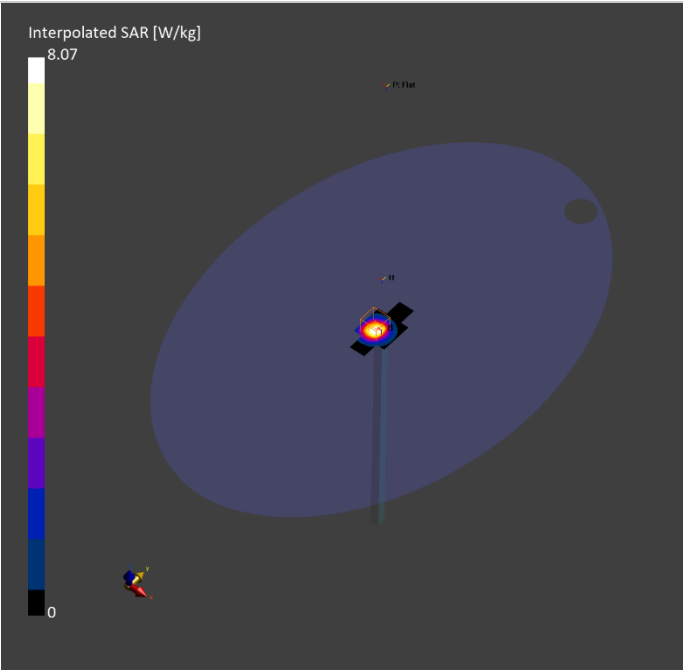
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3500-2026-07-03	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-03	2026-07-03
psSAR1g [W/kg]	6.06	6.53
psSAR10g [W/kg]	2.49	2.57
Power Drift [dB]	-0.00	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.3
Dist 3dB Peak [mm]		9.0



System Check_HSL3700_260610

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3700 MHz D3700V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3700	CW, -	3700.000, 50	6.09	3.02	38.4

Hardware Setup

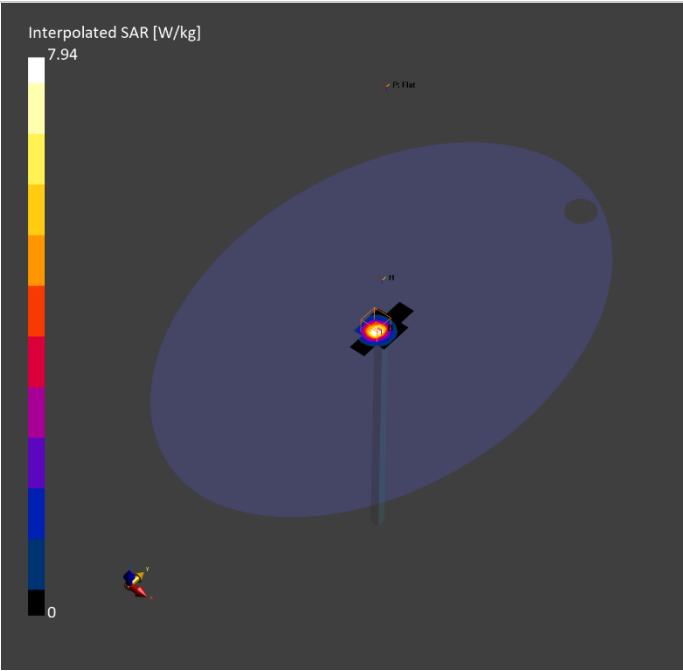
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3700-2026-06-10	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-10	2026-06-10
psSAR1g [W/kg]	5.88	6.28
psSAR10g [W/kg]	2.27	2.36
Power Drift [dB]	-0.00	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		73.4
Dist 3dB Peak [mm]		8.6



System Check_HSL3700_260630

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3700 MHz D3700V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3700	CW, -	3700.000, 50	6.09	3.10	36.3

Hardware Setup

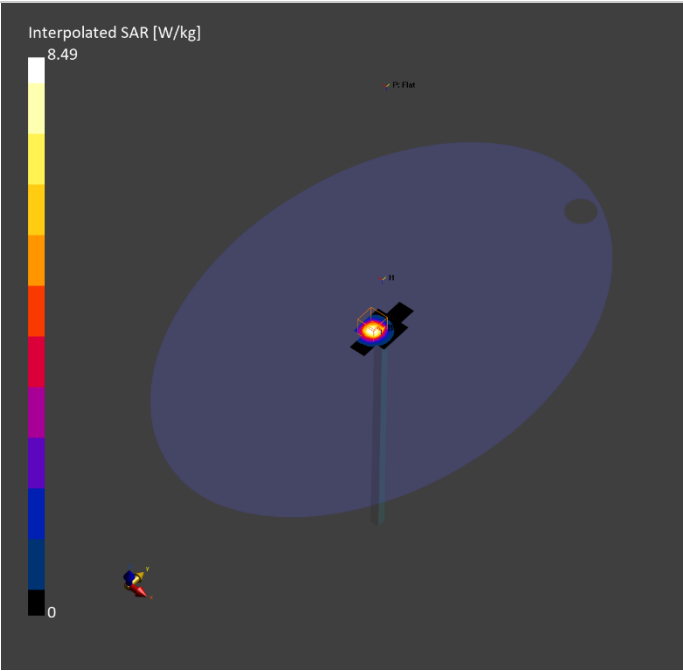
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3700-2026-06-30	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-06-30	2026-06-30
psSAR1g [W/kg]	6.28	6.86
psSAR10g [W/kg]	2.52	2.58
Power Drift [dB]	-0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		74.4
Dist 3dB Peak [mm]		9.0



System Check_HSL3700_260704

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole 3700 MHz D3700V2,	10.0 x 10.0 x 285.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3700	CW, -	3700.000, 50	6.09	3.05	36.1

Hardware Setup

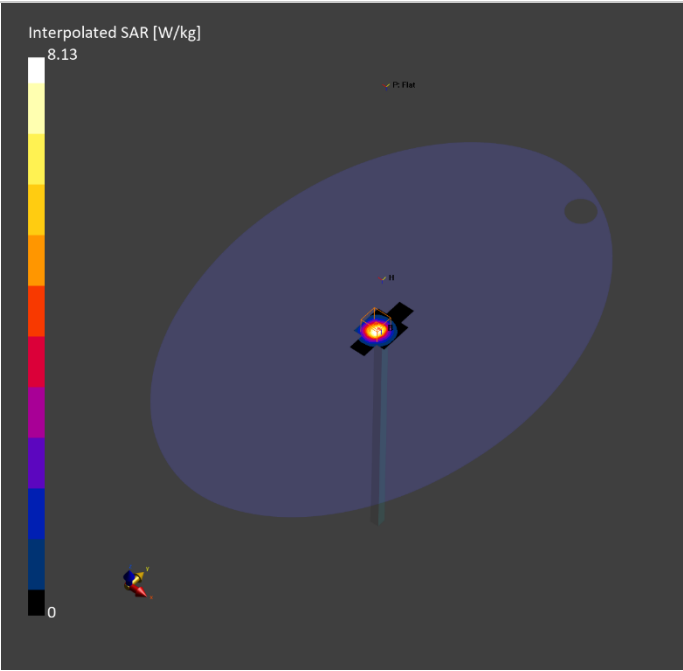
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3700-2026-07-04	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-04	2026-07-04
psSAR1g [W/kg]	6.02	6.42
psSAR10g [W/kg]	2.33	2.41
Power Drift [dB]	-0.00	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		73.4
Dist 3dB Peak [mm]		9.0



System Check_HSL3900_260701

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
D3900MHzV2 - D3900V2,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3900	CW, -	3900.000, 50	6.06	3.28	37.8

Hardware Setup

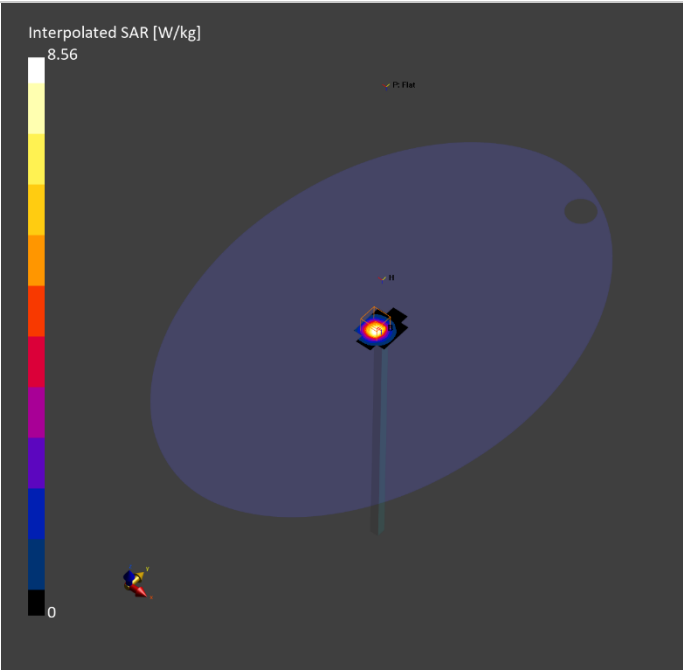
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3900-2026-07-01	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 60.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-01	2026-07-01
psSAR1g [W/kg]	6.31	6.91
psSAR10g [W/kg]	2.41	2.49
Power Drift [dB]	0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		73.7
Dist 3dB Peak [mm]		8.6



System Check_HSL3900_260705

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
D3900MHzV2 - D3900V2,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D3900	CW, -	3900.000, 50	6.06	3.31	38.0

Hardware Setup

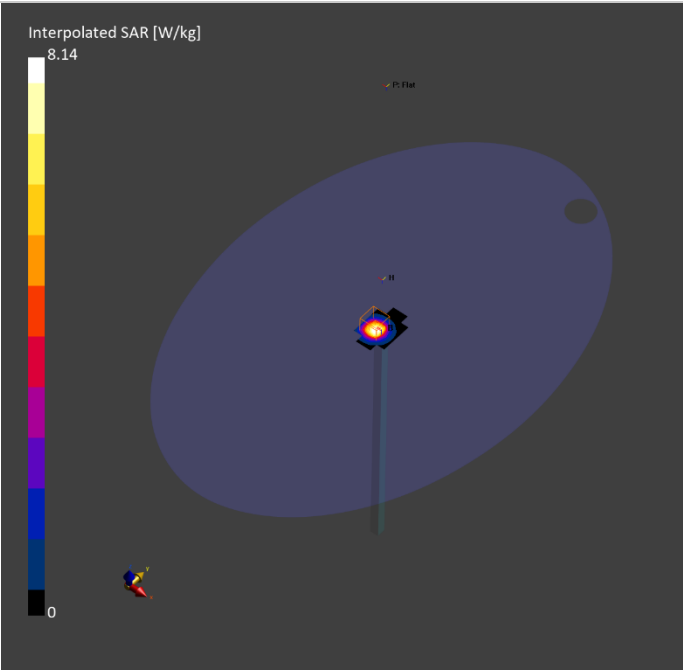
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL3900-2026-07-05	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 60.0	28.0 x 28.0 x 28.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-05	2026-07-05
psSAR1g [W/kg]	6.02	6.60
psSAR10g [W/kg]	2.31	2.38
Power Drift [dB]	0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		73.3
Dist 3dB Peak [mm]		8.1



System Check_HSL5250_260706

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole D5GHzV2,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D5GHz	CW, -	5250.000, 25	5.35	4.53	37.2

Hardware Setup

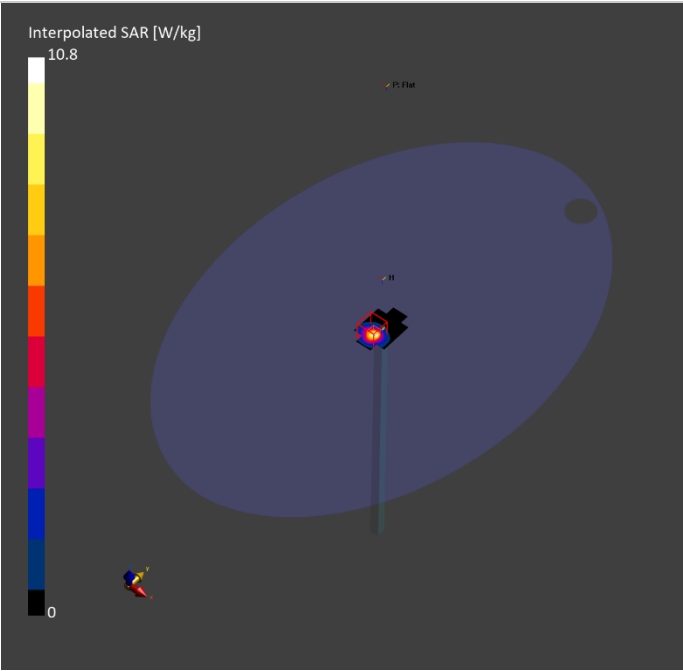
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL5250-2026-07-06	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1779, 2025-07-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 60.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-06	2026-07-06
psSAR1g [W/kg]	6.64	7.66
psSAR10g [W/kg]	1.99	2.19
Power Drift [dB]	0.02	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		62.2
Dist 3dB Peak [mm]		7.4



System Check_HSL5250_260707

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Dipole D5GHzV2,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D5GHz	CW, -	5250.000, 25	5.35	4.48	36.8

Hardware Setup

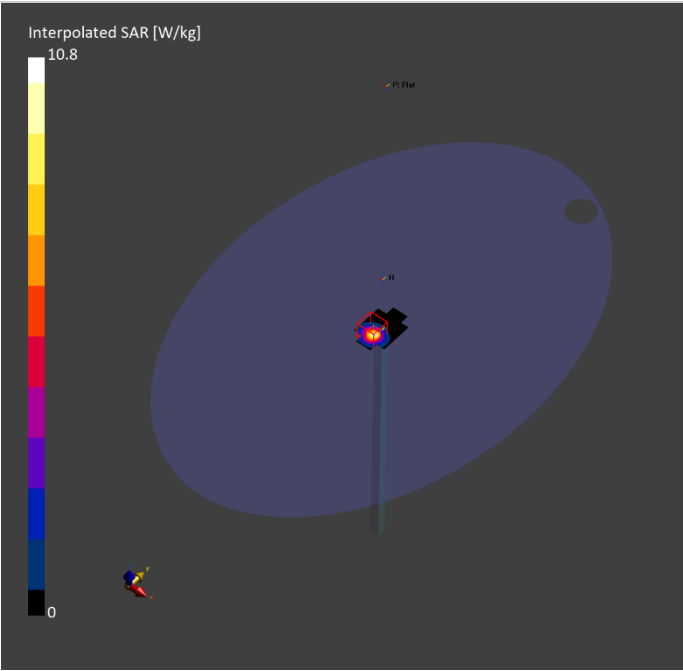
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL5250-2026-07-07	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1288, 2025-07-17

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 60.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-07	2026-07-07
psSAR1g [W/kg]	6.66	7.69
psSAR10g [W/kg]	1.99	2.20
Power Drift [dB]	0.02	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		61.9
Dist 3dB Peak [mm]		7.4



System Check_HSL5600_260708

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
D5GHzV2 - SN1055,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D5GHz	CW, -	5600.000, 60	4.93	4.95	36.8

Hardware Setup

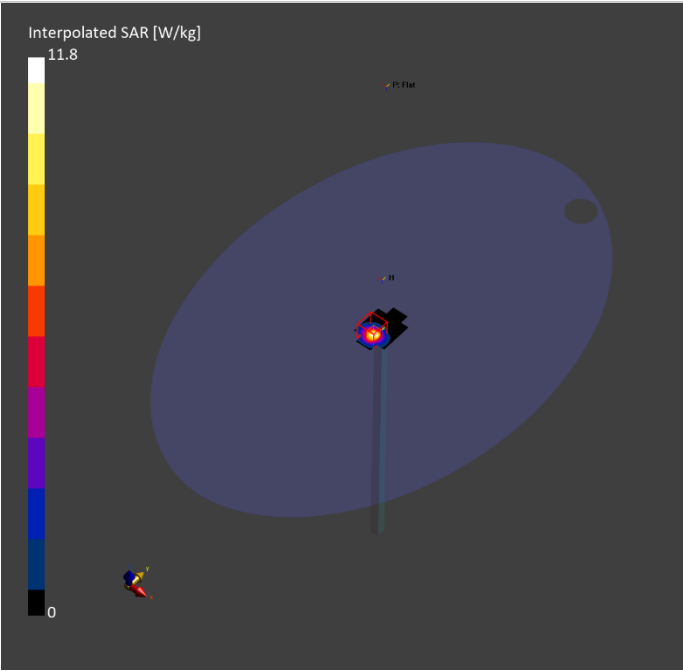
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL5600-2026-07-08	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1288, 2025-07-17

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 60.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-08	2026-07-08
psSAR1g [W/kg]	7.42	8.58
psSAR10g [W/kg]	2.21	2.44
Power Drift [dB]	0.02	0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		59.3
Dist 3dB Peak [mm]		7.6



System Check_HSL5750_260709

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
D5GHzV2 - SN1055,	10.0 x 10.0 x 300.0		Dipole

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, -	FRONT, 10.00	D5GHz	CW, -	5750.000, 75	5.02	5.12	36.4

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2199	HSL5750-2026-07-09	EX3DV4 - SN7802, 2025-07-21	DAE4 Sn1288, 2025-07-17

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 60.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-07-09	2026-07-09
psSAR1g [W/kg]	6.63	7.71
psSAR10g [W/kg]	1.97	2.18
Power Drift [dB]	0.03	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		57.8
Dist 3dB Peak [mm]		7.6

